NTMS4917N

Product Preview

Power MOSFET

30 V, 10.2 A, N-Channel, SO-8

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Printers

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain	Steady	T _A = 25°C	I _D	8.3	Α
Current $R_{\theta JA}$ (Note 1)	State	T _A = 70°C		6.6	
Power Dissipation $R_{\theta JA}$ (Note 1)	Steady State	T _A = 25°C	P _D	1.28	W
Continuous Drain	Steady	T _A = 25°C	I _D	6.8	Α
Current R _{θJA} (Note 2)	State	T _A = 70°C		5.5	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.88	W
Continuous Drain	Steady State	T _A = 25°C	I _D	10.2	Α
Current $R_{\theta JA}$, $t \le 10 s$ (Note 1)	State	T _A = 70°C		8.2	
Power Dissipation $R_{\theta JA}$, $t \le 10 \text{ s(Note 1)}$	Steady State	T _A = 25°C	P _D	1.95	W
Pulsed Drain Current $T_A = 25^{\circ}C$, $t_p = 10 \mu s$			I _{DM}	32	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 150	ç
Source Current (Body Diode)			IS	2.4	Α
Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25^{\circ}C$, $V_{DD} = 30$ V, $V_{GS} = 10$ V, $I_L = XX$ A_{pk} , $L = XX$ MH , $R_G = 25$ Ω)			E _{AS}	TBD	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	97.4	°C/W
Junction-to-Ambient – $t \le 10 \text{ s (Note 1)}$	$R_{\theta JA}$	64	
Junction-to-Foot (Drain)	$R_{\theta JF}$	25.9	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	142.4	

- 1. Surfacemounted on FR4 board using 1 in sq pad size, 1 oz Cu.
- 2. Surfacemounted on FR4 board using the minimum recommended pad size.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

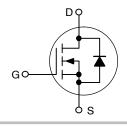


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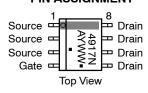
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	11 mΩ @ 10 V	10.2 A
30 V	15 mΩ @ 4.5 V	10.2 A

N-Channel





MARKING DIAGRAM/ PIN ASSIGNMENT



4917N = Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMS4917NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NTMS4917N

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

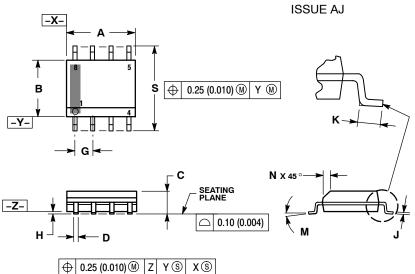
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				TBD		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	.,,	T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 2$	250 μA	1.0	1.6	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				TBD		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	7.5 A		8.5	11	mΩ
		V _{GS} = 4.5 V, I _D =	6.5 A		11.6	15	1
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D =	7.5 A		TBD		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE	•		-	-	<u>-</u>
Input Capacitance	C _{iss}				1132		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz,	V _{DS} = 25 V		414		
Reverse Transfer Capacitance	C _{rss}		•		216		1
Total Gate Charge	Q _{G(TOT)}				10.8		nC
Threshold Gate Charge	Q _{G(TH)}	.,			TBD		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}$	$V, I_D = 7.5 A$		3.5		1
Gate-to-Drain Charge	Q_{GD}		ŀ		5.4		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V	/, I _D = 7.5 A		20		nC
SWITCHING CHARACTERISTICS (No	ote 4)		-		•	•	•
Turn-On Delay Time	t _{d(on)}				TBD		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS} =	: 15 V.		TBD		1
Turn-Off Delay Time	t _{d(off)}	I _D = 1.0 A, R _G =	6.0 Ω [′]		TBD		1
Fall Time	t _f		•		TBD		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS		•		•	•	•
Forward Diode Voltage	V_{SD}	., .,,	T _J = 25°C		0.8	1.0	V
		$V_{GS} = 0 \text{ V}, I_{S} = 2.0 \text{ A}$	T _J = 125°C		TBD		
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d_{IS}/d_t = 100 A/ μ s, I_S = 2.0 A			TBD		ns
Charge Time	t _a				TBD		1
Discharge Time	t _b				TBD		1
Reverse Recovery Charge	Q _{RR}				TBD		nC
PACKAGE PARASITIC VALUES			•				•
Source Inductance	L _S				0.66		nH
Drain Inductance	L _D	T _A = 25°C			0.2		
Gate Inductance	L _G				1.5		
Gate Resistance	R _G				0.67		Ω

Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

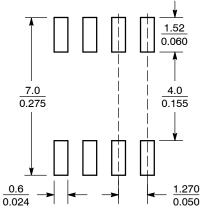
NTMS4917N

PACKAGE DIMENSIONS

SOIC-8 CASE 751-07



SOLDERING FOOTPRINT*



(mm inches SCALE 6:1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER. 3. DIMENSION A AND B DO NOT INCLUDE

- MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW
- STANDARD IS 751-07.

	MILLIMETERS		INC	INCHES		
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
С	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27 BSC		0.05	0 BSC		
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
М	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

STYLE 12:

- PIN 1. SOURCE SOURCE 2
 - 3. SOURCE
 - 4. GATE
 - 5. DRAIN
 - 6. DRAIN
 - DRAIN 8 DRAIN

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